Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/042,480	CHANG ET AL.
Examiner	Art Unit
Liang-che Alex Wang	2155

	SEAR	CHED	
Class	Subclass	Date	Examiner
707	1-10, 100- 104.1, 200-205	11/21/2005	LW
709	232, 242	11/21/2005	LW

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
			1

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
Updated EAST Search: USPAT, EPO, JPO, DERWENT, IBMTDB, USPUB	11/21/2005	LW
·		
	·	
	c	
		<u>.</u>